

N-channel 200V, 110A, 9.2 mΩ Power MOSFET

Features

- 200V, 110A, $R_{DS(on).max}=11.5m\Omega @ V_{GS} = 10V$
- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Green device available

Applications

- Motor Drives
- UPS
- DC-DC Converter
- Telecom
- Battery management

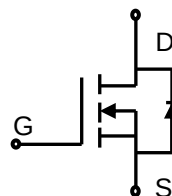
Product Summary

V_{DSS}	200V
$R_{DS(on).typ}@V_{GS}=10V$	9.2mΩ
I_D	110A

Pin Configuration



TO-247



N-Channel MOSFET



Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	200	V
Continuous drain current ¹⁾ ($T_C = 25^\circ\text{C}$, Silicon limit)	I_D	110	A
($T_C = 25^\circ\text{C}$, Package limit)		130	A
($T_C = 100^\circ\text{C}$, Silicon limit)		65	A
Pulsed drain current ²⁾	I_{DM}	430	A
Gate-Source voltage	V_{GSS}	± 20	V
Avalanche energy ³⁾	E_{AS}	1122	mJ
Power Dissipation	P_D	320	W
Storage Temperature Range	T_{STG}	-55 to +150	$^\circ\text{C}$
Operating Junction Temperature Range	T_J	-55 to +150	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.26	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient ⁴⁾	$R_{\theta JA}$	62	$^\circ\text{C/W}$
Soldering temperature, wave soldering only allowed at leads. (1.6mm from case for 10s)	T_{sld}	260	$^\circ\text{C}$

Package Marking and Ordering Information

Device	Device Package	Marking	Units/Tube
IRFP4668PBF	TO-247	4668PBF	30

Electrical Characteristics

 $T_J = 25^{\circ}\text{C}$ unless otherwise noted

Parameter	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Static characteristics						
Drain-source breakdown voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	200	---	---	V
Gate threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.4	---	3.6	V
Drain-source leakage current	I_{DSS}	$V_{DS}=200V, V_{GS}=0V, T_J=25^{\circ}\text{C}$	---	---	1	μA
		$V_{DS}=200V, V_{GS}=0V, T_J=150^{\circ}\text{C}$	---	---	10	mA
Gate leakage current, Forward	I_{GSSF}	$V_{GS}=20V, V_{DS}=0V$	---	---	100	nA
Gate leakage current, Reverse	I_{GSSR}	$V_{GS}=-20V, V_{DS}=0V$	---	---	-100	nA
Drain-source on-state resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=50A, T_J=25^{\circ}\text{C}$	---	9.2	11.5	m Ω
		$T_J=150^{\circ}\text{C}$	---	17.04	---	
Forward transconductance	g_{fs}	$V_{DS}=50V, I_D=50A$	---	86	---	S
Dynamic characteristics						
Input capacitance	C_{iss}	$V_{DS}=100V, V_{GS}=0V, f=250kHz$	---	5237	---	pF
Output capacitance	C_{oss}		---	384	---	
Reverse transfer capacitance	C_{rss}		---	12	---	
Turn-on delay time	$t_{d(on)}$	$V_{DD}=100V, V_{GS}=10V, I_D=50A, R_G=10\Omega$	---	23	---	ns
Rise time	t_r		---	46	---	
Turn-off delay time	$t_{d(off)}$		---	62	---	
Fall time	t_f		---	20	---	
Gate resistance	R_g	$V_{GS}=0V, V_{DS}=0V, f=1MHz$	---	1.3	---	Ω
Gate charge characteristics						
Gate to source charge	Q_{gs}	$V_{DS}=100V, I_D=50A, V_{GS}=10V$	---	23.5	---	nC
Gate to drain charge	Q_{gd}		---	9.9	---	
Gate charge total	Q_g		---	63.5	---	
Gate plateau voltage	$V_{plateau}$		---	4.9	---	V
Output Charge	Q_{oss}	$V_{DS}=50V, V_{GS}=0V$	---	170	---	nC
Drain-Source diode characteristics and Maximum Ratings						
Continuous Source Current	I_S		---	---	110	A
Pulsed Source Current	I_{SM}		---	---	430	A
Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_S=50A, T_J=25^{\circ}\text{C}$	---	---	1.1	V
Reverse Recovery Time	t_{rr}	$I_S=50A, di/dt=200A/\mu s, T_J=25^{\circ}\text{C}$	---	130	---	ns
Reverse Recovery Charge	Q_{rr}		---	670	---	nC

Notes:

- Limited by maximum junction temperature and duty cycle.
- Repetitive Rating: Pulse width limited by maximum junction temperature.
- $V_{DD}=50V, V_{GS}=10V, L=0.5mH, I_{AS}=67A$, Starting $T_J=25^{\circ}\text{C}$.
- The value of R_{thJA} is measured by placing the device in a still air box which is one cubic foot.

Electrical Characteristics Diagrams

Figure 1. Typ. Output Characteristics

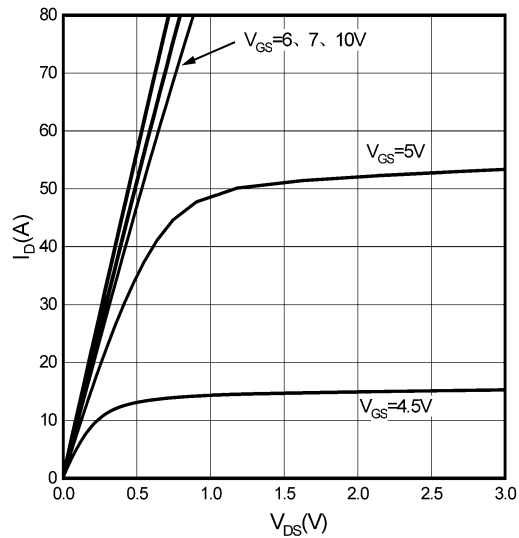


Figure 2. Transfer Characteristics

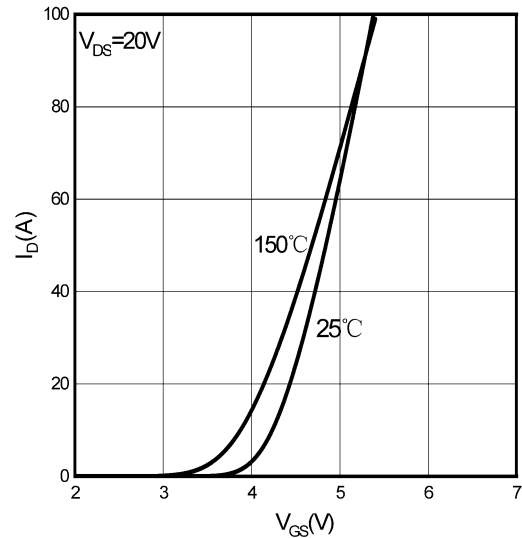


Figure 3. On-Resistance vs. Drain Current

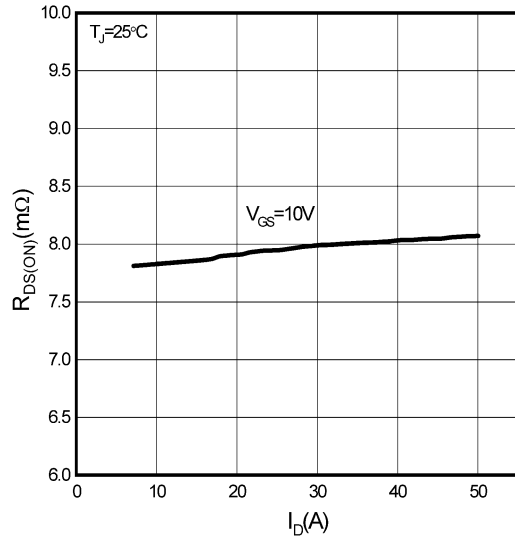


Figure 4. On-Resistance vs. Temperature

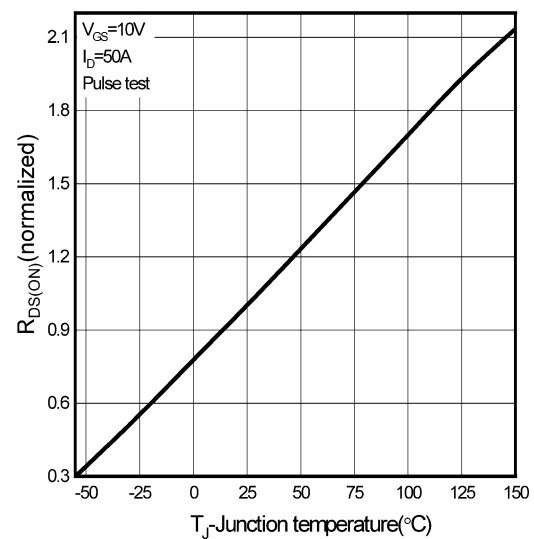


Figure 5. Breakdown Voltage vs. Temperature

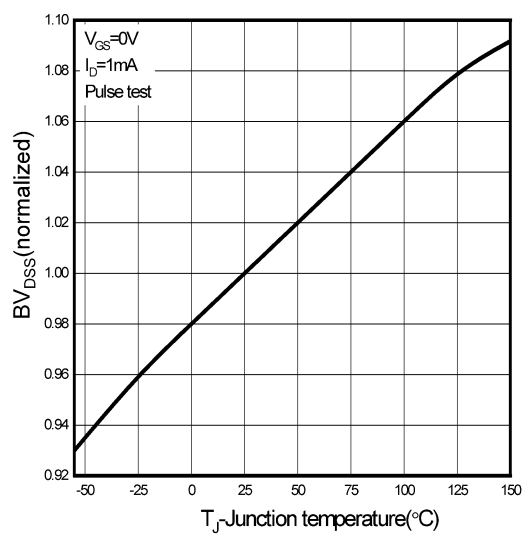


Figure 6. Threshold Voltage vs. Temperature

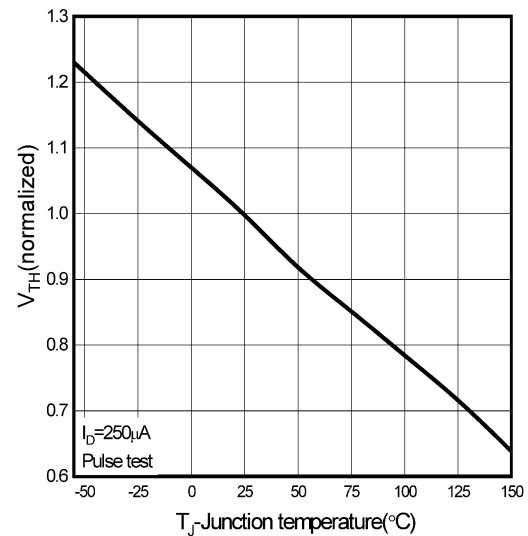


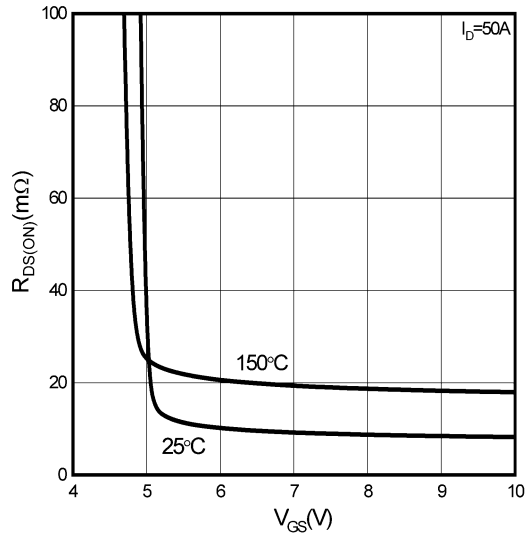
Figure 7. $R_{DS(on)}$ vs. Gate Voltage


Figure 8. Body-Diode Characteristics

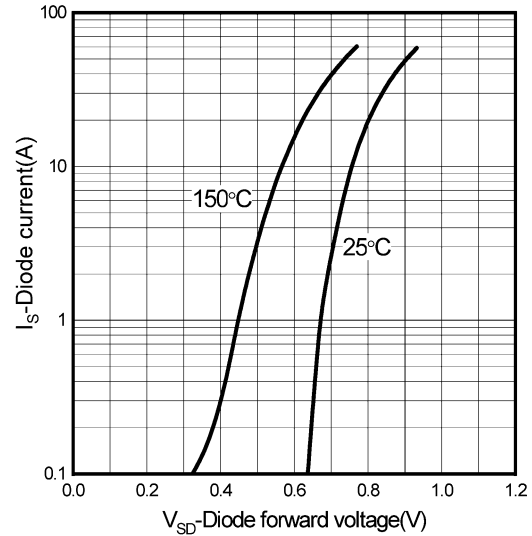


Figure 9. Capacitance Characteristics

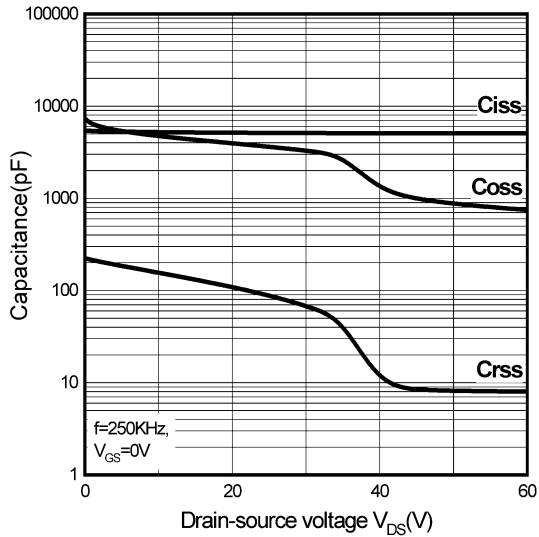


Figure 10. Gate Charge Characteristics

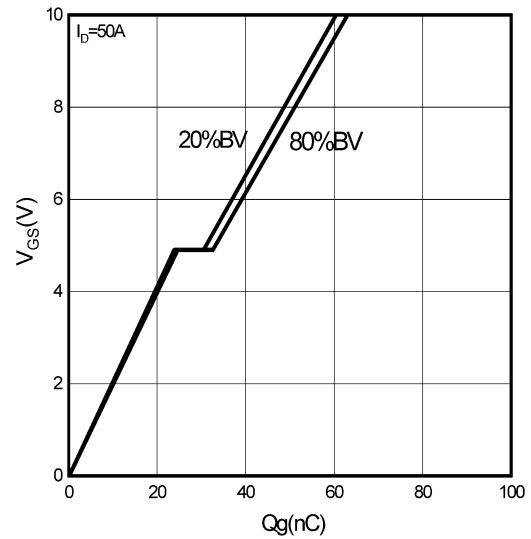


Figure 11. Drain Current Derating

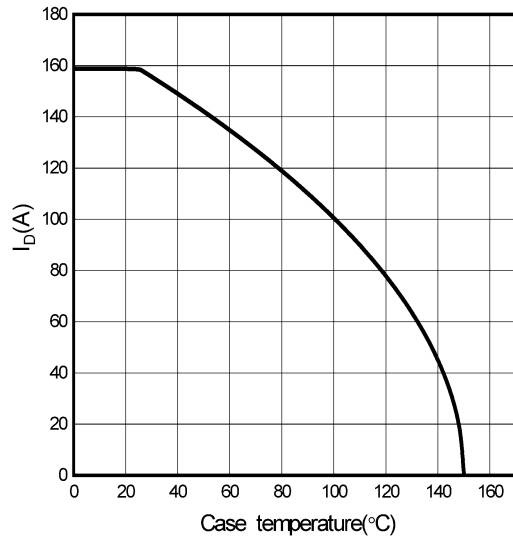


Figure 12. Power Dissipation vs. Temperature

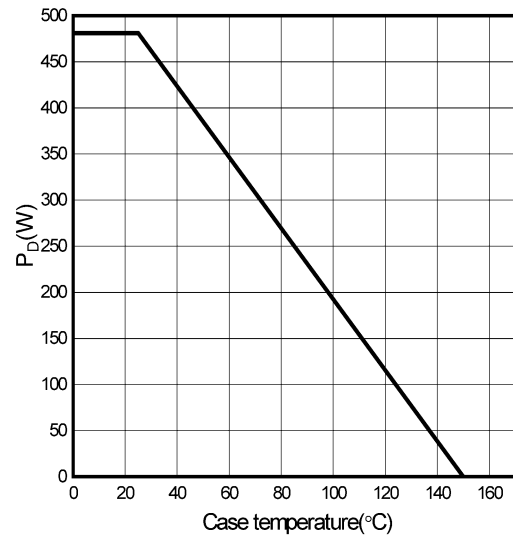
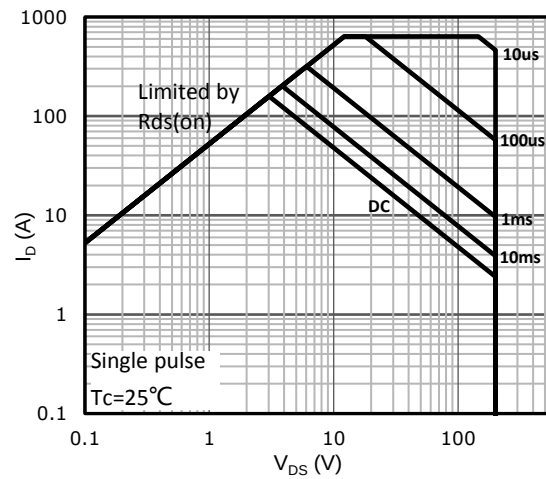
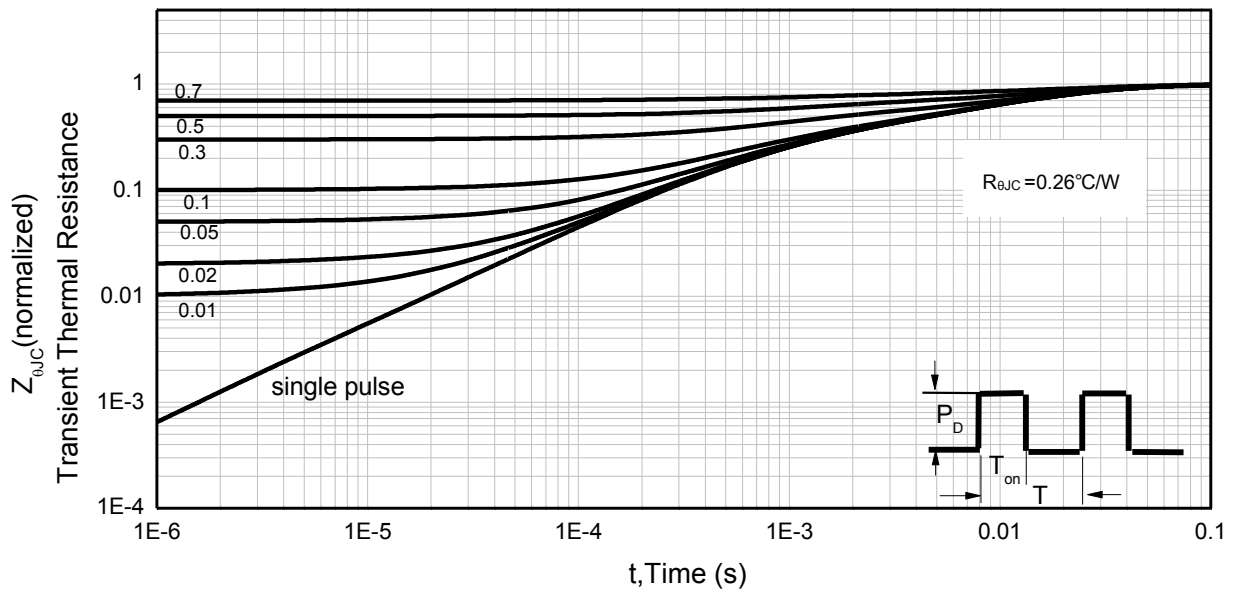
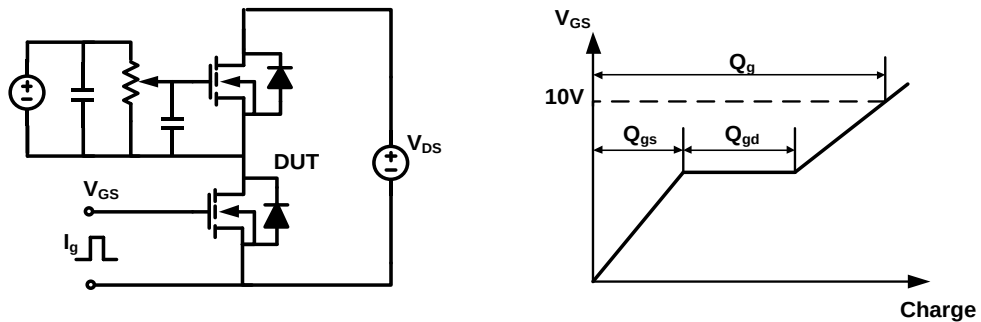


Figure 13. Safe Operating Area

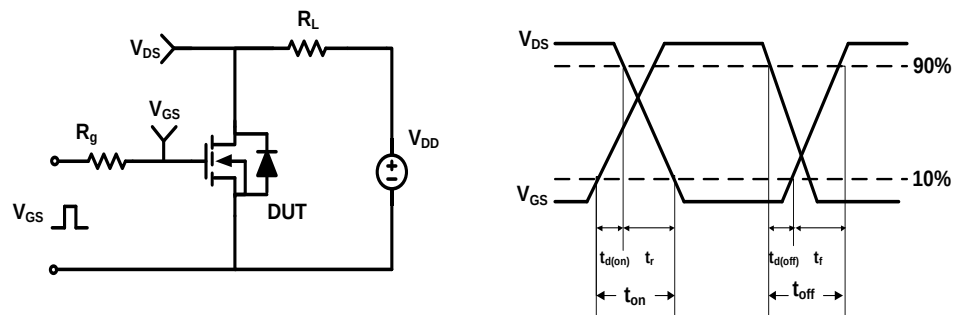

Figure 14. Normalized Maximum Transient Thermal Impedance (R_{thJC})


Test Circuit & Waveforms

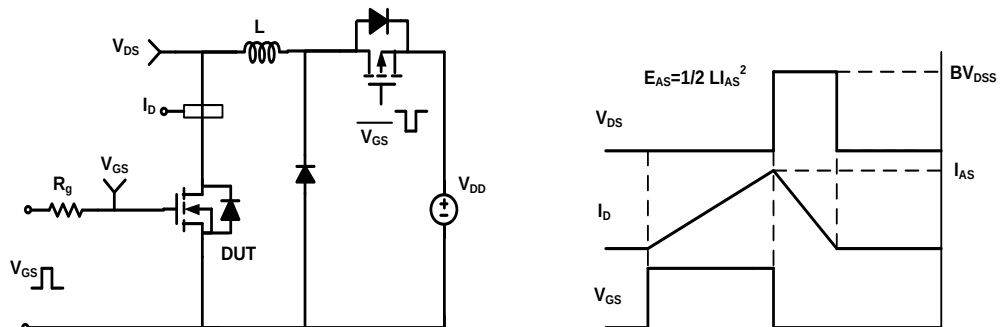
Gate Charge Test Circuit & Waveform



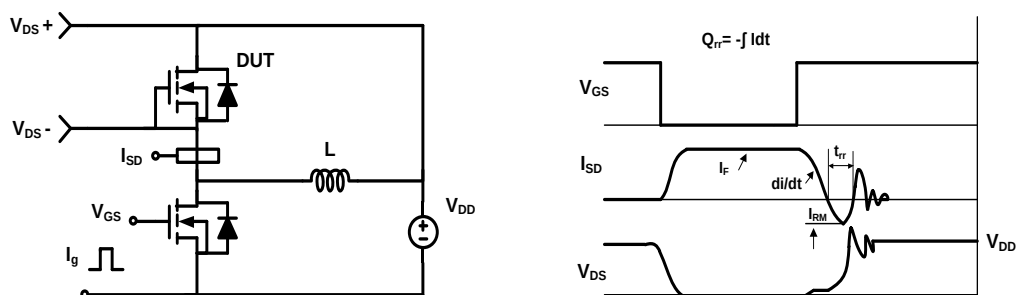
Resistive Switching Test Circuit & Waveform



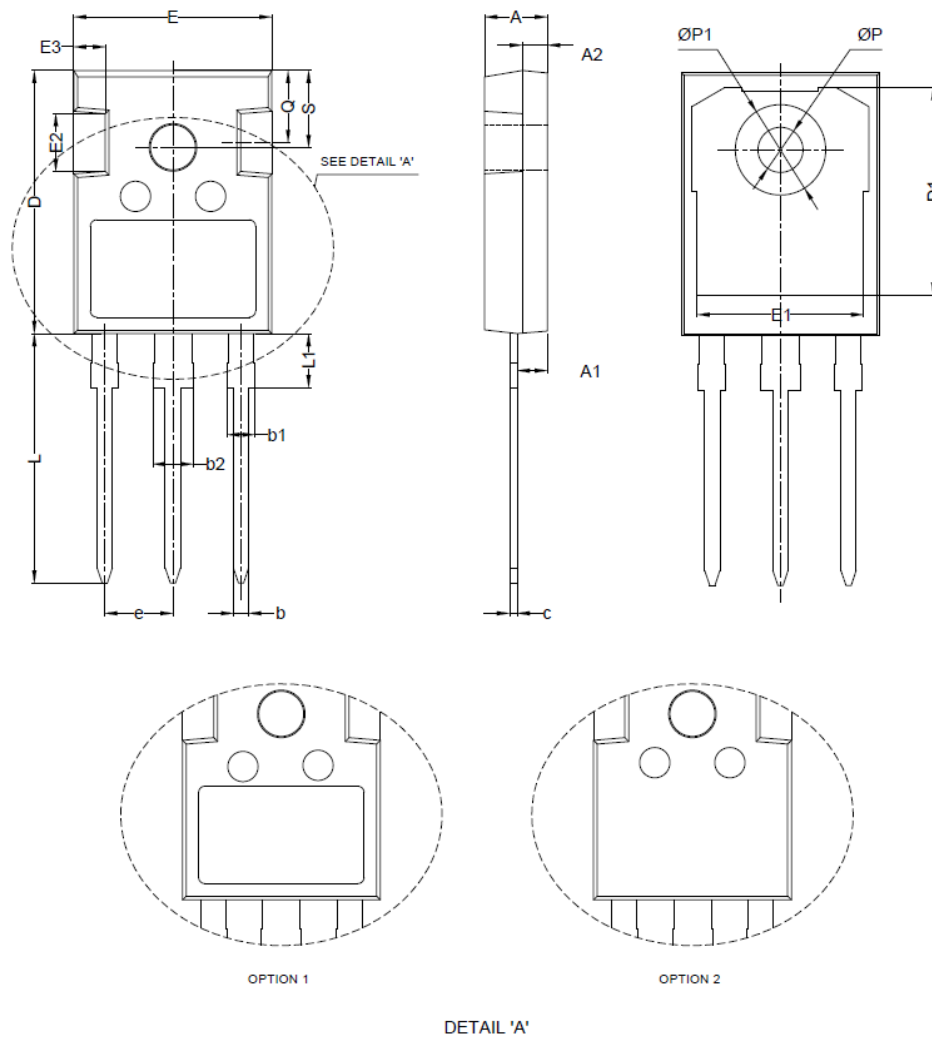
Unclamped Inductive Switching (UIS) Test Circuit & Waveform



Diode Recovery Test Circuit & Waveform



Mechanical Dimensions for TO-247



SYMBOLS	MILLIMETERS		INCHES	
	MIN	MAX	MIN	MAX
A	4.80	5.21	0.189	0.205
A1	2.21	2.59	0.087	0.102
A2	1.85	2.16	0.073	0.085
b	1.07	1.36	0.042	0.054
b1	1.90	2.41	0.075	0.095
b2	2.87	3.38	0.113	0.133
c	0.51	0.75	0.020	0.030
D	20.70	21.30	0.815	0.839
D1	16.25	17.65	0.640	0.695
E	15.50	16.13	0.610	0.635
E1	12.38	13.60	0.487	0.535
E2	3.68	5.20	0.145	0.205
E3	1.00	2.70	0.039	0.106
e	5.44 BSC		0.214 BSC	
L	19.62	20.32	0.772	0.800
L1	-	4.40	-	0.173
ØP	3.40	3.80	0.134	0.150
ØP1	-	7.40	-	0.291
Q	5.49	6.00	0.216	0.236
S	6.04	6.30	0.238	0.248